

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567757	OHNO ET AL.
	Examiner	Art Unit
	Jafar Parsa	1621

SEARCHED

Class	Subclass	Date	Examiner
570	165, 177, 178	8/17/08	jp

SEARCH NOTES

Search Notes	Date	Examiner
EAST	8/17/08	jp
inventor name search	8/17/08	jp

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
570	165, 177, 178	8/17/2008	JP

--	--